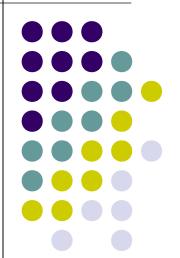
Pattern Recognition Support Vector Machines

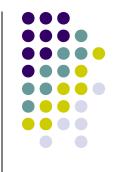
Francesco Tortorella





University of Cassino and Southern Latium Cassino, Italy

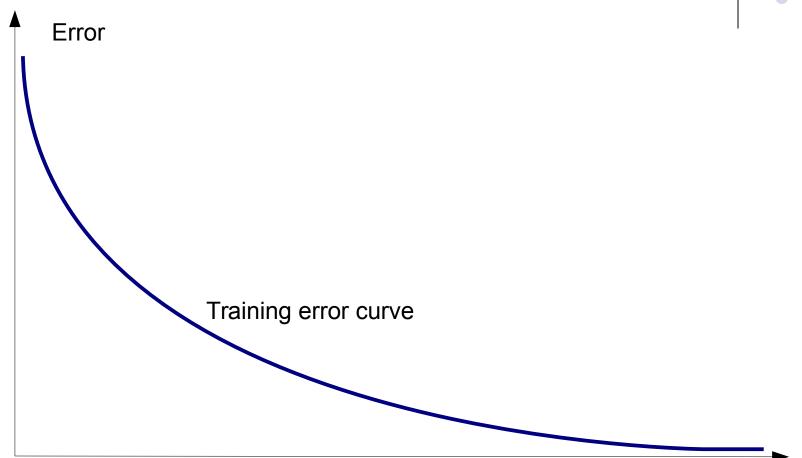




- The central question is that our learning algorithm must perform well on previously unseen inputs → Generalization
- When training a machine learning model, we can compute some error measure on the training set → Training Error
- How the training error varies during the training process?

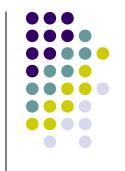
Overfitting and underfitting





Number of iterations

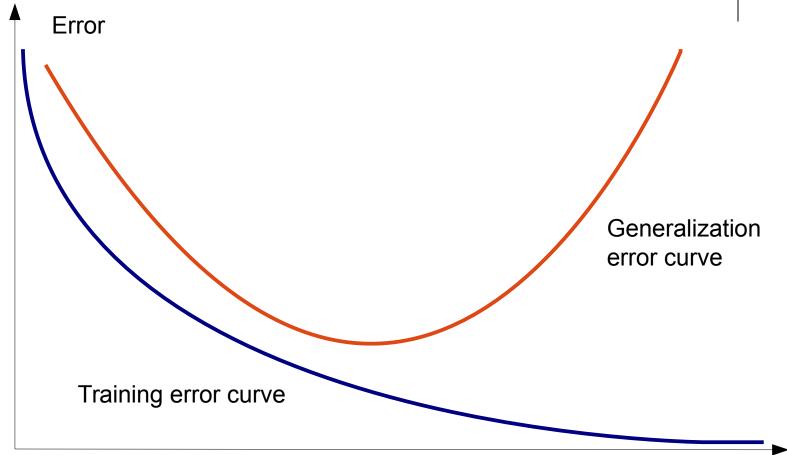




- We could go on until the training error is low, but we want that the Test Error (or Generalization Error) must be low as well.
- We tipically estimate the generalization error on a test set containing samples collected separately from the training set.
- What if we observe how the generalization error varies during the training phase?

Overfitting and underfitting





Number of iterations

Pattern Recognition

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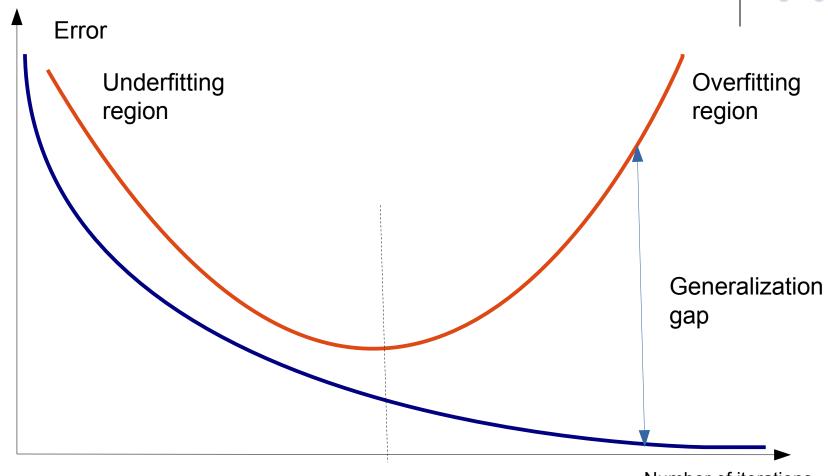




- We can observe two different problems.
- Underfitting: when the model is not able to obtain a sufficently low error on the training set
- Overfitting: when the gap between the training error and the test error is too large

Overfitting and underfitting



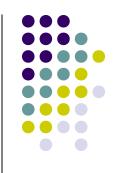


Number of iterations

Pattern Recognition

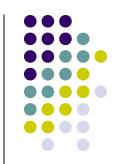
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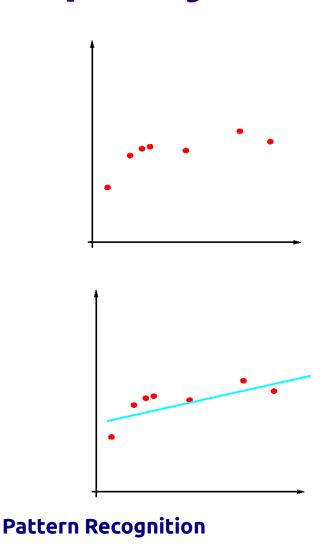
Overfitting, underfitting, capacity



- We can control if a model is more likely to underfit or to overfit by altering its capacity.
- Informally, the capacity is the ability of a model to fit a wide variety of functions.
- One way to control the capacity of a learning algorithm is by choosing its hypothesis space, the set of functions that the algorithm is capable to select as the solution.

Overfitting, underfitting, capacity





University of

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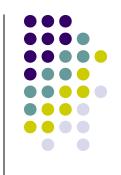
University of Cassino and S.L.

Measuring the capacity VC Dimension



- Statistical Learning Theory provides some measures fo evaluating the capacity of a model
- The most well known measure is the Vapnik-Cervonenkis dimension (VC dimension) that measures the capacity of a binary classifier
- It is defined as the largest possible value of *m* for which there exists some training set of *m* different samples that the classifier can label arbitrarily.

VC Dimension



2.1. The VC Dimension

The VC dimension is a property of a set of functions $\{f(\alpha)\}$ (again, we use α as a generic set of parameters: a choice of α specifies a particular function), and can be defined for various classes of function f. Here we will only consider functions that correspond to the two-class pattern recognition case, so that $f(\mathbf{x}, \alpha) \in \{-1, 1\} \ \forall \mathbf{x}, \alpha$. Now if a given set of l points can be labeled in all possible 2^l ways, and for each labeling, a member of the set $\{f(\alpha)\}$ can be found which correctly assigns those labels, we say that that set of points is shattered by that set of functions. The VC dimension for the set of functions $\{f(\alpha)\}$ is defined as the maximum number of training points that can be shattered by $\{f(\alpha)\}$. Note that, if the VC dimension is h, then there exists at least one set of h points that can be shattered, but it in general it will not be true that every set of h points can be shattered.



C.J.C. Burges

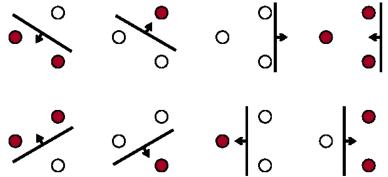
A Tutorial on Support Vector Machines for Pattern Recognition 1998

Pattern Recognition

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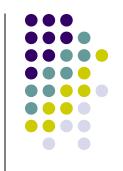
VC dimension

- Example:
 - Binary classification problem in R²
 - $f(\alpha)$ family of the oriented hyperplanes (perceptron)
- With *m*=3 there is some set for which it is possible to label arbitrarily all the samples



- With *m*=4 it is not possible for any set of samples (xor problem).
- The VC dimension of $f(\alpha)$ in R^2 is 3.
 - In general, in R^D VC(f(α))=D+1





- Which link between capacity and learning?
- Our goal is to learn a function f: X → {-1, +1}
 from the labelled samples of a limited training set
- In other words, we want learn f from the training set

$$(\mathbf{x}_1, y_1), \dots, (\mathbf{x}_N, y_N) \in X \times \{-1, +1\}$$

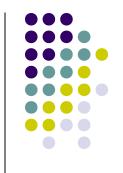




• If we assume that data is generated from some unknown (but fixed) probability distribution $P(\mathbf{x}, y)$, the goal is to minimize the **expected error** (or **expected risk**) on a test set, also drawn from $P(\mathbf{x}, y)$

$$R[f] = \int \frac{1}{2} |f(\mathbf{x}) - y| dP(\mathbf{x}, y)$$

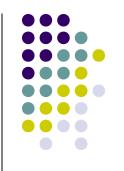




- Actually, we cannot minimize the expected risk, because $P(\mathbf{x}, y)$ is unknown.
- What we could do is to minimize instead the average risk over the training set (empirical risk):

$$R_{emp}[f] = \frac{1}{N} \sum_{i=1}^{N} \frac{1}{2} |f(\mathbf{x}_i) - y_i|$$





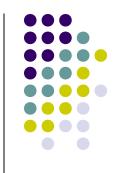
- Minimizing the empirical risk (training error), does not imply a small test error.
- The following bound has been demonstrated (Vapnik):

$$R[f] \le R_{emp}[f] + \sqrt{\frac{h(log(2N/h) + 1) - log(\eta/4)}{N}}$$

with probability $1 - \eta$

 h is the VC dimension of the function f while N is the number of samples in the training set.





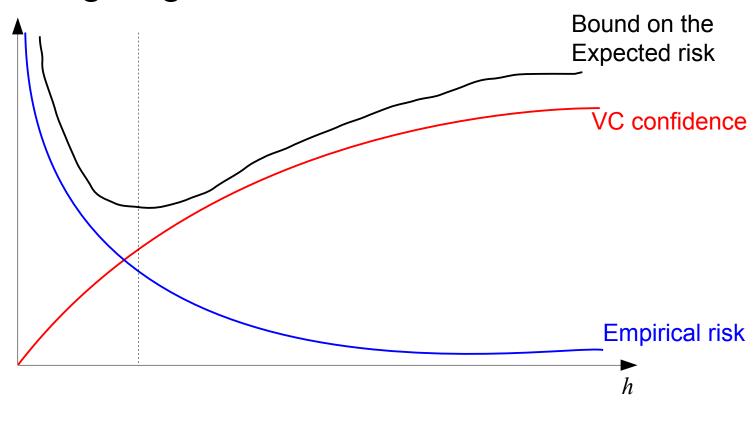
- The second term on RHS is called VC confidence and increases with the VC dimension h.
- In order to limit the expected risk, we have to minimize the sum on RHS, i.e. we have to minimize both
 - Empirical risk
 - VC confidence

Structural Risk Minimization

Limiting the expected risk



Conflicting targets



Pattern Recognition

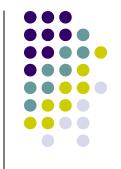
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- The SRM cannot be directly achieved in many situations
 - VC dimension difficult to evaluate
 - Very difficult optimization problem
 - Very large bound
- Possible in the set of linear models

Support Vector Machines



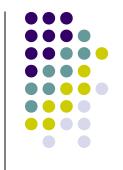
- Let us consider a 2 class problem for which we have available a training set S={x_i,y_i}, where:
 - x_i is the feature vector of the i-th sample
 - y_i is the label of the class to which the i-th sample belongs
- In order to simplify the expressions, assume that the labels are ±1.
- Assume that the two classes are "linearly separable". This
 means that it exists an hyperplane w·x+b=0 such that:

$$w \cdot x_i + b > 0$$
 if $y_i = +1$
 $w \cdot x_i + b > 0$ if $y_i = +1$
 $w \cdot x_i + b < 0$ if $y_i = -1$

Pattern Recognition

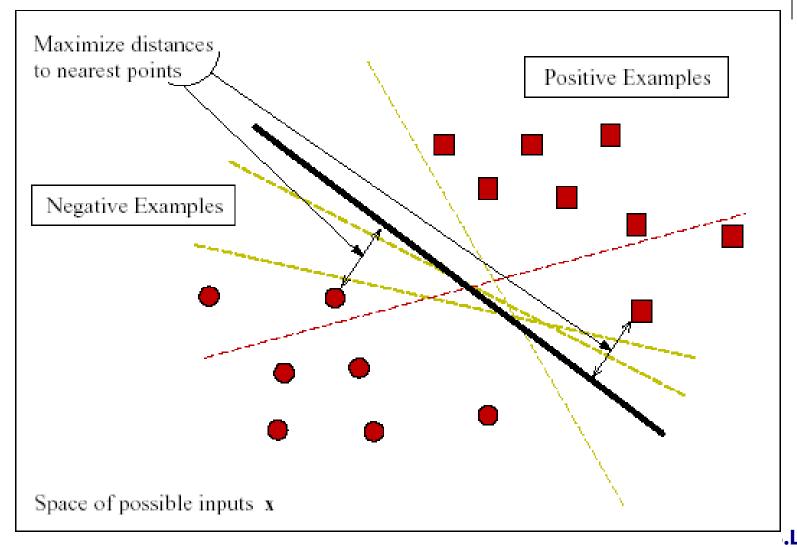
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- Consider the point x₊ (x₋) with label +1 (-1) that is the nearest to the hyperplane; call d₊ (d₋) such distance and define *margin* of the hyperplane the sum of the distances d₊+ d₋.
- If the two classes are linearly separable, there are several hyperplanes separating the classes.
- We consider the hyperplane with the maximum margin.

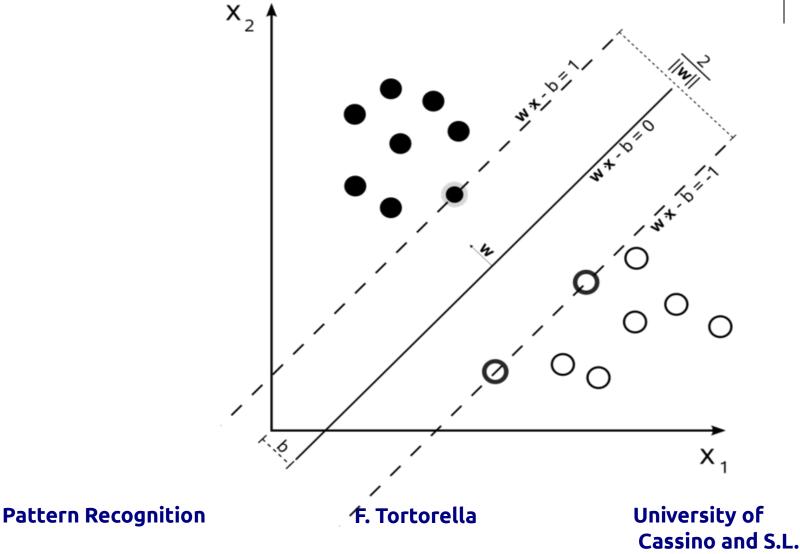






- We can scale w and b in such a way that, in correspondence of the nearest points, we have w·x₊+b=+1 e w·x₋+b=-1.
- In this case d₊=d₋ = 1/||w|| and the margin becomes 2/||w||.







 Vapnik demonstrated that the VC dimension of a separating hyperplane with a margin m is bounded as follows

$$h \le \min\left(\left\lceil \frac{R^2}{m^2} \right\rceil, d\right) + 1$$

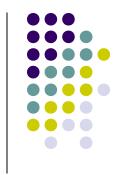
where d is the dimensionality of the input space, and R is the radius of the smallest sphere containing all the input vectors

- By maximizing the margin we are thus minimizing the VC dimension.
- Since the separating hyperplane has zero empirical error (it correctly separates all the training examples), maximizing the margin will also minimize the upper bound on the expected risk

Pattern Recognition

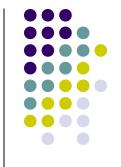
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- As a consequence, the best possible generalization is given by the maximum margin hyperplane, that is the optimal separating hyperplane (OSH).
- The LDF corresponding to the OSH is called Support Vector Machine (SVM).

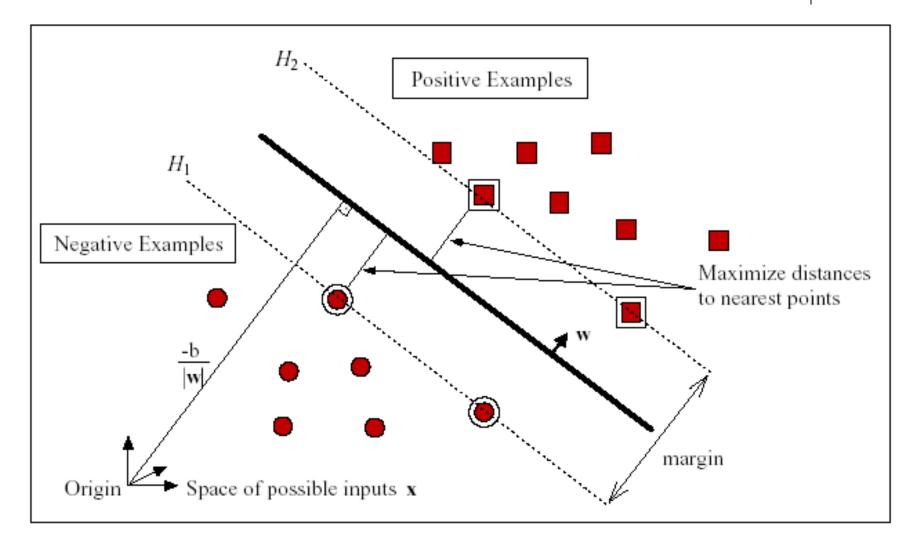




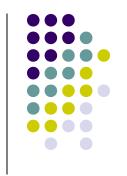
- By construction, we have $(w \cdot x_i + b) y_i 1 \ge 0$ for each (x_i, y_i) .
- The nearest points satisfy the equation (w·x_i+b) y_i -1 = 0 that specifies two hyperplanes H₁ and H₂ parallel to the OSH (no man's land).
- The points on H₁ and H₂ are the support vectors (SV). If the SVs change, the OSH is modified.

OSH and Support Vectors





Building the OSH



To obtain the OSH we must solve the optimization problem:

$$\min_{\mathbf{w},b} \frac{1}{2} ||\mathbf{w}||^2$$
 Margin maximization

subject to
$$y_i(\mathbf{w} \cdot \mathbf{x}_i + b) - 1 \ge 0$$
 $\forall i$ Empirical risk minimization

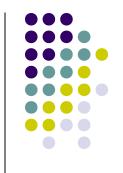
This leads to the minimization of the Lagrangian:

$$L_P \equiv \frac{1}{2} \|\mathbf{w}\|^2 - \sum_{i=1}^{\ell} \alpha_i y_i \left(\mathbf{w} \cdot \mathbf{x}_i + b\right) + \sum_{i=1}^{\ell} \alpha_i, \quad \alpha_i \ge 0.$$

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Building the OSH



This is a convex quadratic programming problem with solution :

$$\mathbf{w} = \sum_{i=1}^{\ell} \alpha_i y_i \mathbf{x}_i$$

- In the expression above only some Lagrange multipliers α_i will be greater than zero (*sparsness*).
- As a consequence, only the corresponding points of the training set will be support vectors and affect the position of the OSH.

Building the OSH



• At the end, the LDF will be:

$$f(\mathbf{x}) = \mathbf{w} \cdot \mathbf{x} + b$$

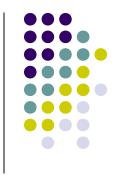
$$f(\mathbf{x}) = \left(\sum_{i=1}^{l} \alpha_i y_i \mathbf{x_i}\right) \cdot \mathbf{x} + b$$

$$f(\mathbf{x}) = \sum_{i=1}^{l} \alpha_i y_i \left(\mathbf{x_i} \cdot \mathbf{x} \right) + b$$

Pattern Recognition

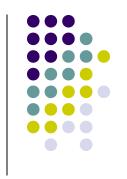
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- In principle, the SVM cannot handle problems where the classes are not separable.
- Two possible (not mutually exclusive) approaches:
 - Relaxing the correct classification costraints and accepting a certain number of errors on the training set
 - Using non-linear discriminant functions (???)

Relax!



In the first approach, the correct classification constraints are relaxed by introducing positive *slack* $variables \xi_i$:

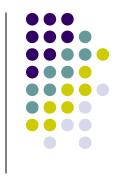
$$\mathbf{w} \cdot \mathbf{x}_i + b \ge +1 - \xi_i$$
, for $y_i = +1$
 $\mathbf{w} \cdot \mathbf{x}_i + b \le -1 + \xi_i$, for $y_i = -1$
 $\xi_i \ge 0$, $\forall i$.

For an error to occurr, the corresponding ξ_i must exceed unity.

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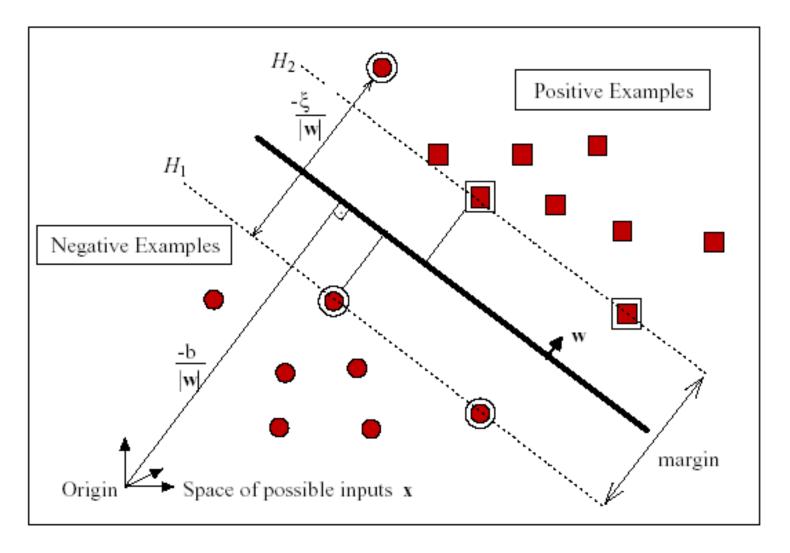
Relax!



- Depending on the value of the corresponding ξ_i the points of the training set will be
 - placed beyond the hyperplanes H₁ and H₂ and correctly classified (ξ_i=0)
 - placed between the hyperplanes H₁ and H₂ and correctly classified (0<ξ_i<1)
 - placed beyond the opposite hyperplane and erroneously classified (ξ_i>1)







Building the OSH with soft margins



 When introducing the slack variables, the Lagrangian becomes:

$$L_P = \frac{1}{2} \|\mathbf{w}\|^2 + C \sum_{i} \xi_i - \sum_{i} \alpha_i \{y_i(\mathbf{w} \cdot \mathbf{x}_i + b) - 1 + \xi_i\} - \sum_{i} \mu_i \xi_i$$

 The parameter C is chosen by the user to assign a penalty to errors.

Building the OSH with soft margins



 The solution obtained for the OSH is in the same form of the previous case:

$$\mathbf{w} = \sum_{i=1}^{N} \alpha_i y_i \mathbf{x}_i$$

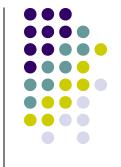
• The only difference is in the values of the Lagrange multipliers α_i that are $0 \le \alpha_i \le C$.

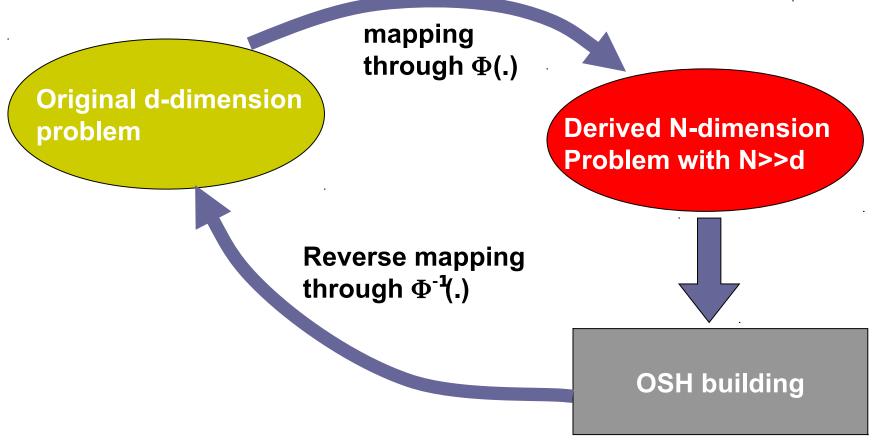




- Another possible approach is to consider a mapping Φ(x) from the feature space to another space with much higher dimension where the corresponding subsets are linearly separable.
- In this way, the classifier is still linear but in a different space.
- Depending on the dimension of the space in which the original problem was formulated, the mapping can lead to transformed space with very high dimensions (~106).

Non linear SVM



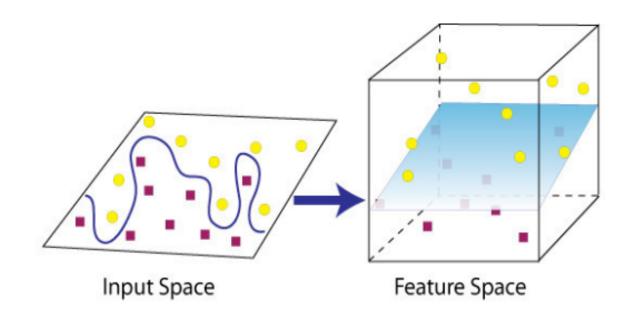


Pattern Recognition

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Feature Transformation

Non-linear SVM



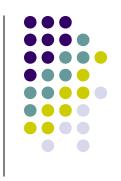
• The Langragian becomes:

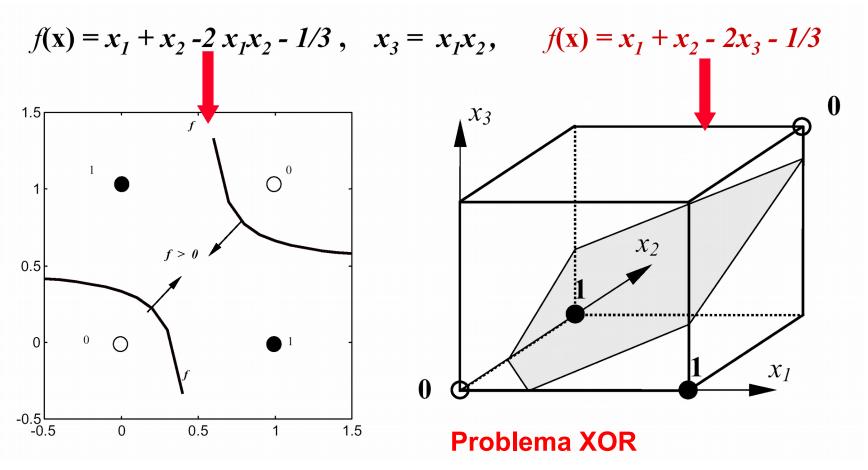
$$L_{P} = \frac{1}{2} ||w||^{2} - \sum_{i=1}^{\ell} \alpha_{i} (y_{i} (w \cdot \Phi(x_{i}) + b) - 1)$$

and has solution: $w = \sum_{i} \alpha_{i} y_{i} \Phi(x_{i})$

The discriminant function is:

$$f(x) = \sum_{i} \alpha_{i} y_{i} \Phi(x_{i}) \Phi(x) + b$$

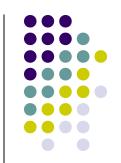


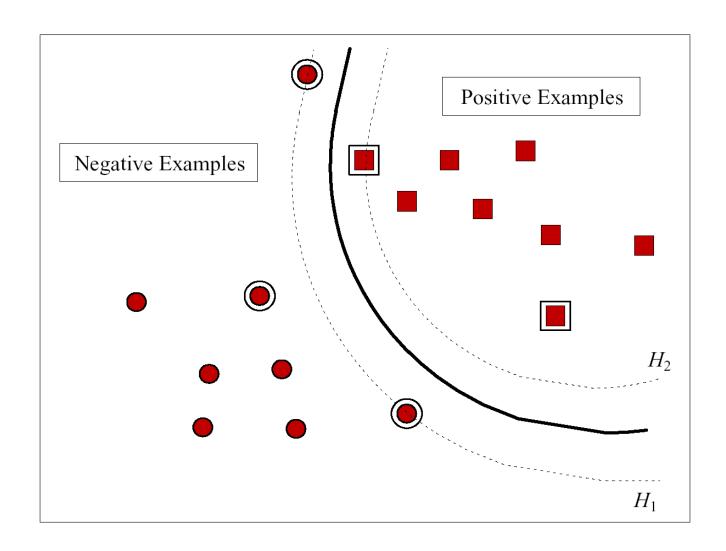


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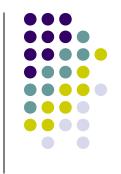
Non-linear SVM





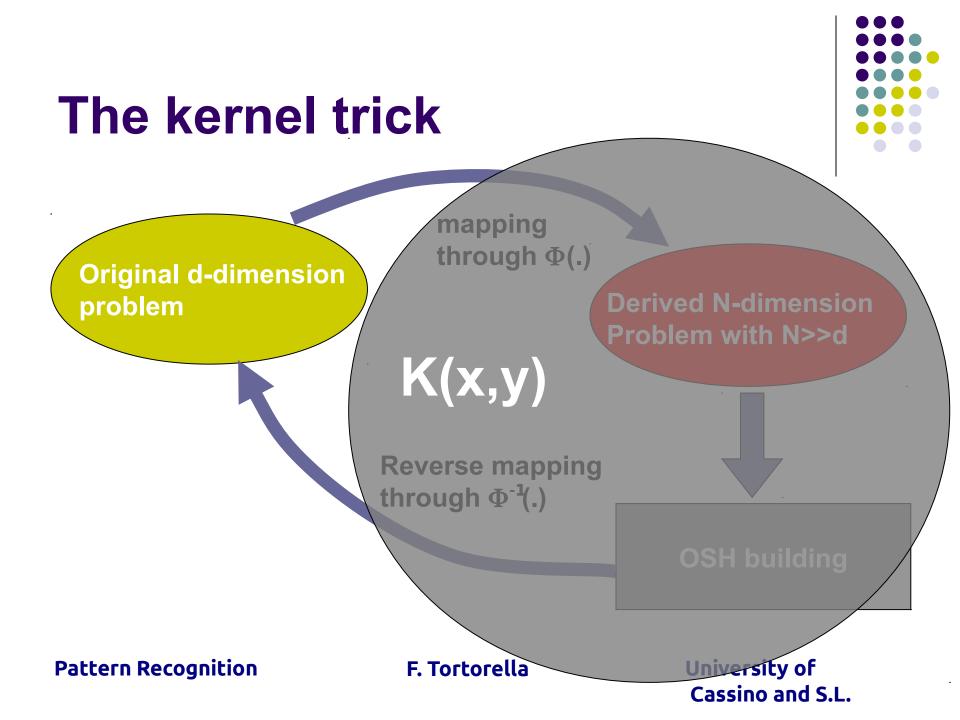
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The kernel trick



- Actually it is not necessary to explicitly use the mapping function $\Phi(.)$.
- What is needed for the training stage and the classification stage is the functional form of the dot product $\Phi(x)\cdot\Phi(y)$.
- The Mercer's theorem guarantees that a kernel function K(x,y) exists such that K(x,y)=Φ(x)·Φ(y).
- As a consequence, the discriminant function becomes:

$$f(x) = \sum_{i} \alpha_{i} y_{i} K(x_{i},x) + b$$



Some kernels



Polynomial

$$K(\mathbf{x}, \mathbf{y}) = (\mathbf{x} \cdot \mathbf{y} + 1)^p$$

Gaussian (RBF)

$$K(\mathbf{x}, \mathbf{y}) = exp\left(-\frac{\|\mathbf{x} - \mathbf{y}\|^2}{2\sigma^2}\right)$$

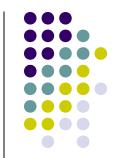
MLP

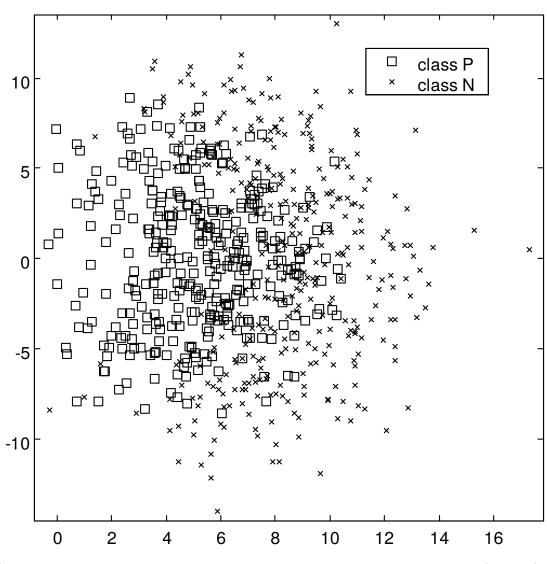
$$K(\mathbf{x}, \mathbf{y}) = tanh\left(\kappa \mathbf{x} \cdot \mathbf{y} - \delta\right)$$

Pattern Recognition

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Example

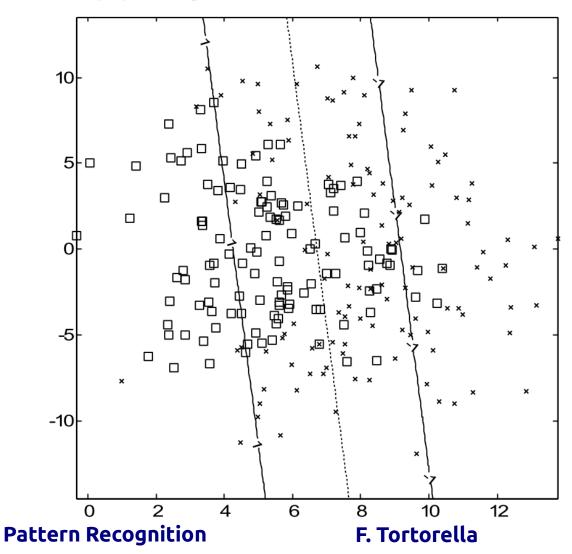




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Linear SVM

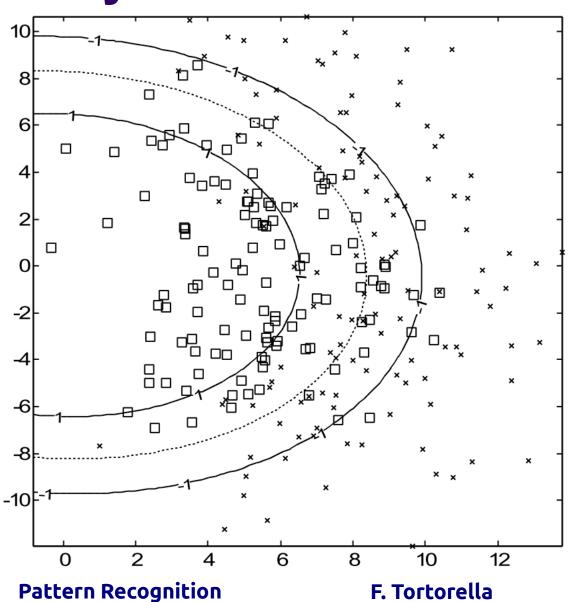




$$K(x,y)=(x\cdot y)$$

163 SV on 240 training samples

Polynomial SVM

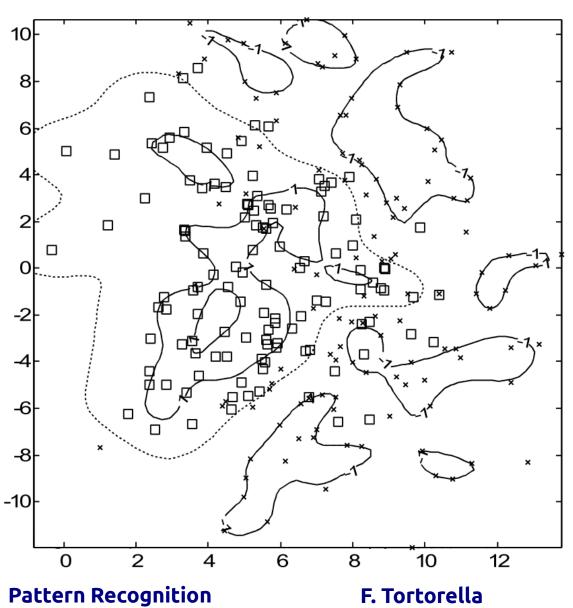




$$K(x,y)=(x\cdot y+1)^2$$

121 SV on 240 training samples

RBF SVM





K(x,y)= exp(-0.5·||x-y||²)

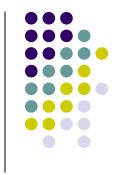
190 SV on 240 training samples





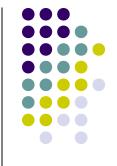
- No problems with local minima
- Optimal solution can be found in polynomial time
- The final results do not depend on random initial weights
- The SVM solution is sparse; it only involves the support vectors
- Excellent generalization capabilities

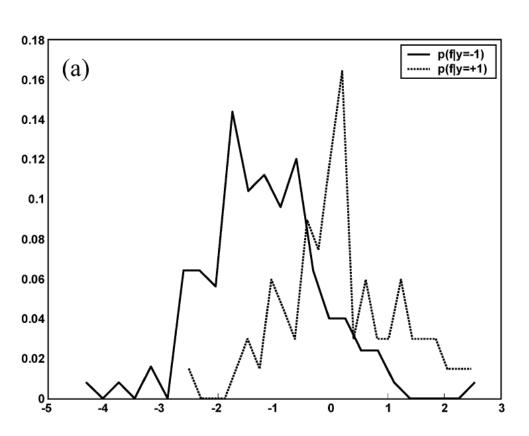
SVM issues

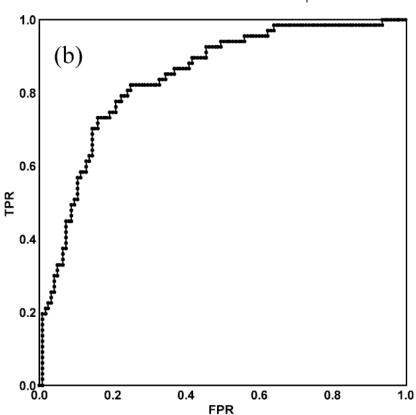


- Kernel to be selected (any principled way?)
- Model parameters to be selected (C, kernel parameters)
- Optimal data representation?
- SVM as a classifier
 - ROC curve?
 - Confidence measure? Postprobabilities?

ROC curve for SVM







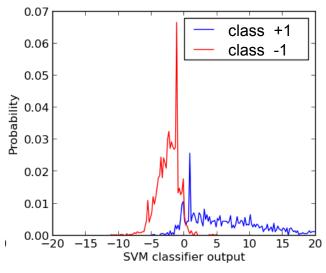
Pattern Recognition

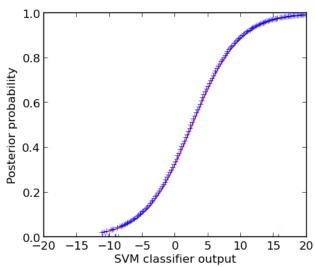
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Postprobabilities

- It is possible to transform the outputs of a SVM into a probability distribution over classes.
- Platt scaling

$$P(y = +1|\mathbf{x}) = \frac{1}{1 + exp(Af(\mathbf{x}) + B)}$$





Pattern Recognition

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